

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10684109	DEVRIES ET AL.
	Examiner	Art Unit
	XIAOZHEN XIE	1646

SEARCHED

Class	Subclass	Date	Examiner
none			

SEARCH NOTES

Search Notes	Date	Examiner
EAST: US-PGPUB, USPAT, EPO, JPO, DERWENT (see search history, attached)	2/14/2008	XZ
CAPLUS, BIOSIS, EMBASE, MEDLINE, PCTFULL (see search history, attached)	2/14/2008	XZ
Inventor names: searched in PALM	2/14/2008	XZ

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
EAST		2/14/2008	XZ
SEQ ID NOs: 3, 5, 51, 53, 58 and 62 by STIC (SCORE)		2/14/2008	XZ